

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/512,066	<b>Applicant(s)/Patent under Reexamination</b> MATSUURA ET AL.
	<b>Examiner</b> Rip A. Lee	<b>Art Unit</b> 1713

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
526	172	12-18-2006	M
526	161	12-18-2006	M
526	336	12-18-2006	M
526	339	12-18-2006	M